

# Device Modeling Report

COMPONENTS:  
DIODE/ GENERAL PURPOSE RECTIFIER / STANDARD  
PART NUMBER: 20GL2C41A  
MANUFACTURER: TOSHIBA  
REMARK: TC= 150C

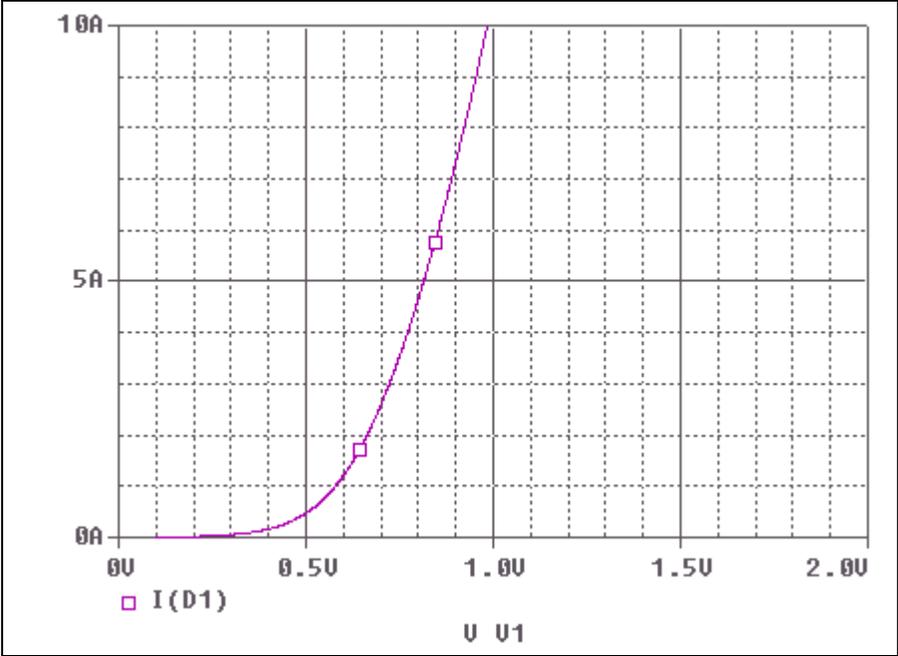


**Bee Technologies Inc.**

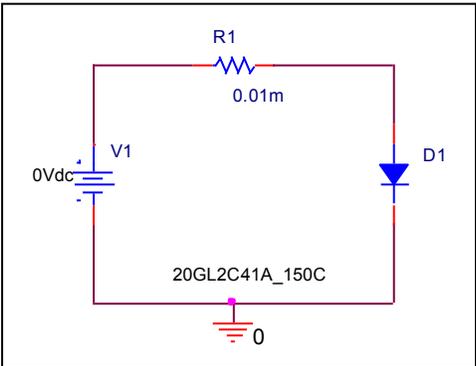
PSpice model parameter	Model description
IS	Saturation Current
N	Emission Coefficient
RS	Series Resistance
IKF	High-injection Knee Current
CJO	Zero-bias Junction Capacitance
M	Junction Grading Coefficient
VJ	Junction Potential
ISR	Recombination Current Saturation Value
BV	Reverse Breakdown Voltage(a positive value)
IBV	Reverse Breakdown Current(a positive value)
TT	Transit Time
EG	Energy-band Gap

# Forward Current Characteristic

## Circuit Simulation Result

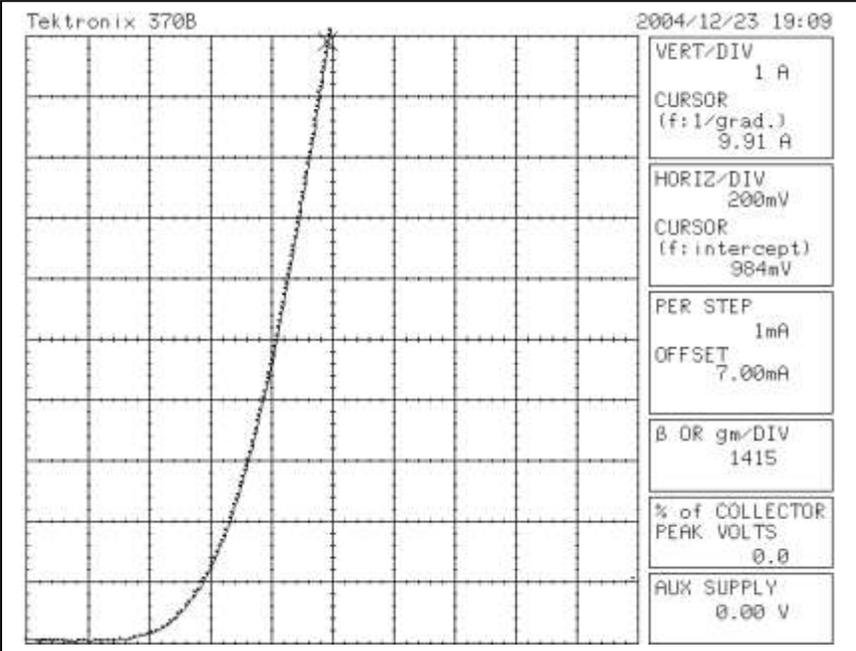


## Evaluation Circuit



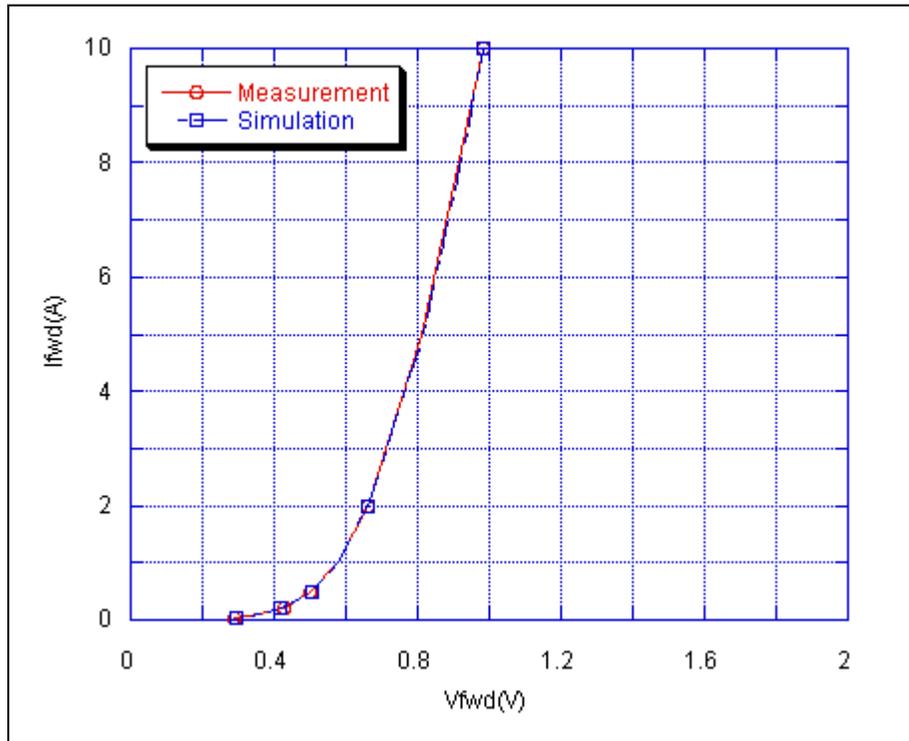
# Forward Current Characteristic

# Reference



## Comparison Graph

### Circuit Simulation Result

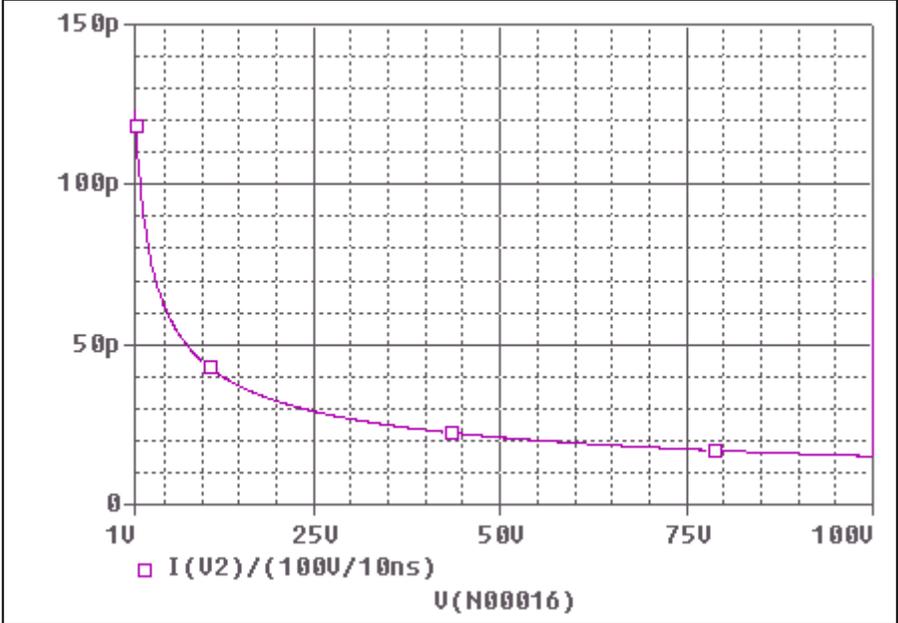


### Simulation Result

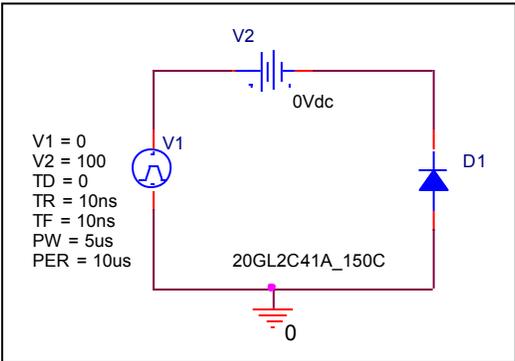
Ifwd(A)	Vfwd(V) Measurement	Vfwd(V) Simulation	%Error
0.05	0.290	0.295	-1.724
0.1	0.358	0.356	0.559
0.2	0.428	0.418	2.290
0.5	0.498	0.505	-1.406
1	0.578	0.578	-0.052
2	0.664	0.663	0.151
5	0.814	0.814	-0.025
10	0.984	0.984	-0.010

# Capacitance Characteristic

## Circuit Simulation Result

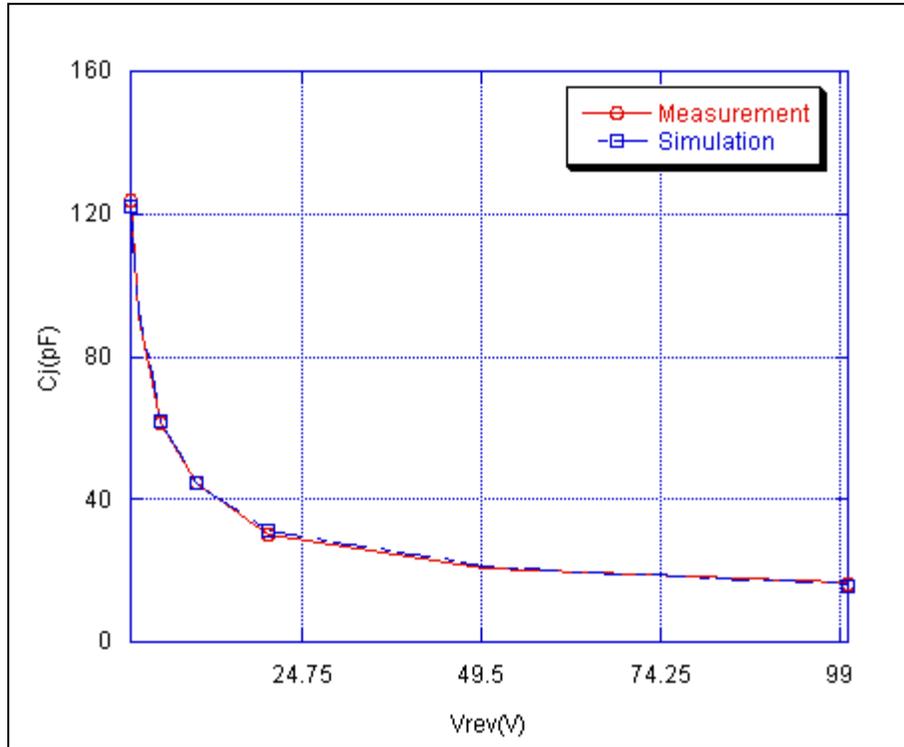


## Evaluation Circuit



## Comparison Graph

### Circuit Simulation Result

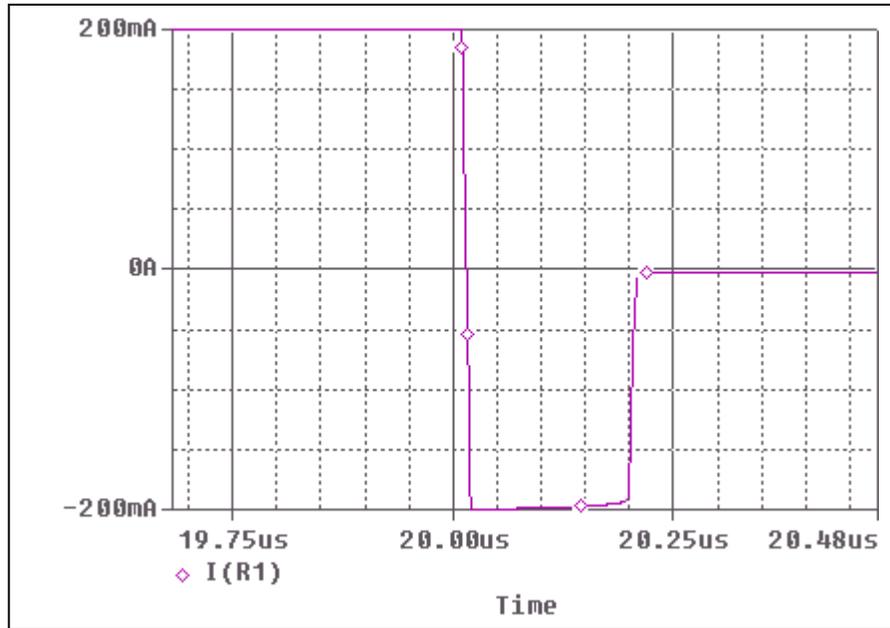


### Simulation Result

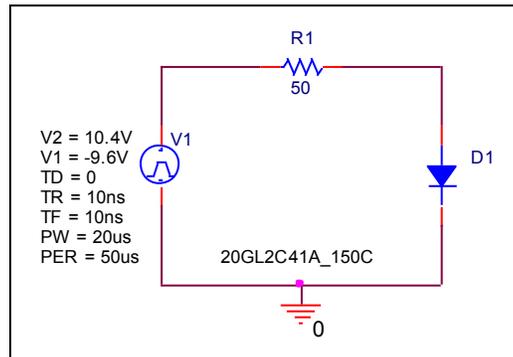
Vrev(V)	Cj(pF) Measurement	Cj(pF) Simulation	%Error
0	265.480	265.480	0.000
1	123.760	122.036	1.393
2	91.730	93.230	-1.635
5	61.220	61.890	-1.094
10	44.500	44.870	-0.831
20	30.050	31.350	-4.326
50	20.390	20.970	-2.845
100	16.300	15.570	4.479

# Reverse Recovery Characteristic

## Circuit Simulation Result



## Evaluation Circuit

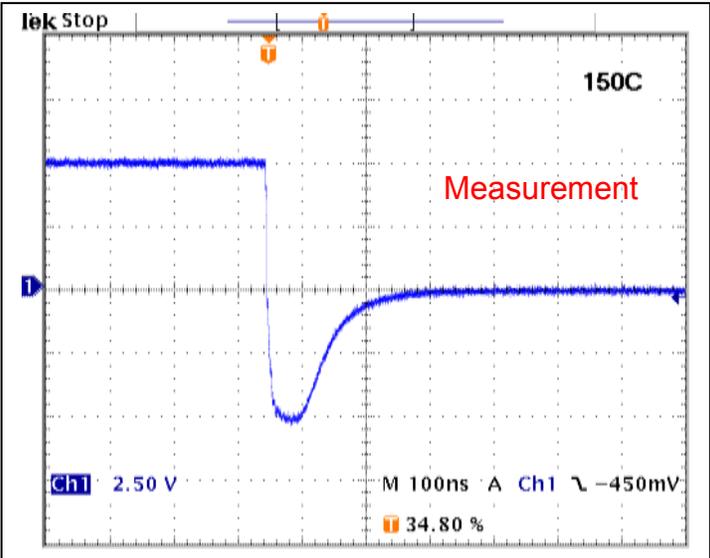


## Compare Measurement vs. Simulation

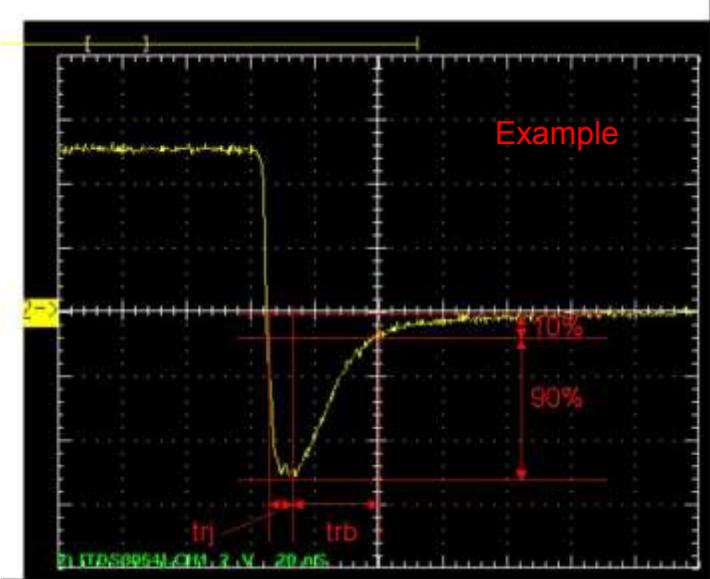
	Measurement		Simulation		%Error
trr	192.00	ns	191.89	ns	0.057

# Reverse Recovery Characteristic

# Reference



Trj =38(ns)  
Trb=154(ns)  
Conditions: Ifwd=Irev=0.02(A), RI=50



Relation between trj and trb